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Application/Control No.	Applicant(s)/Patent under Reexamination
10/073,709	LI, FENG
Examiner	Art Unit
Vheeb Tree	2624

SEARCHED				
Class	Subclass	Date	Examiner	
375	260,267, 285, 346-350	. 5/13/2005	кст	
370	335,342			
455	504,506,			
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Class	Subclass	Date	Examiner	
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SEARCH I (INCLUDING SEAR	NOTES CH STRATE	EGY)	
	DATE		EXMR
Search on EAST Database	5/13/20	005	кст
Inventor Name Search ·			
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